

<b>Notice of References Cited</b>	Application/Control No. 09/678,253	Applicant(s)/Patent Under Reexamination HONMA, HIDEO	
	Examiner Yogesh K Aggarwal	Art Unit 2615	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,266,126	07-2001	Haneda, Norihisa	355/36
*	B	US-2002/0135621	09-2002	Angiulo et al.	345/838
*	C	US-6,545,708	04-2003	Tamayama et al.	348/211.8
*	D	US-2002/0000998	01-2002	SCOTT et al.	345/667
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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